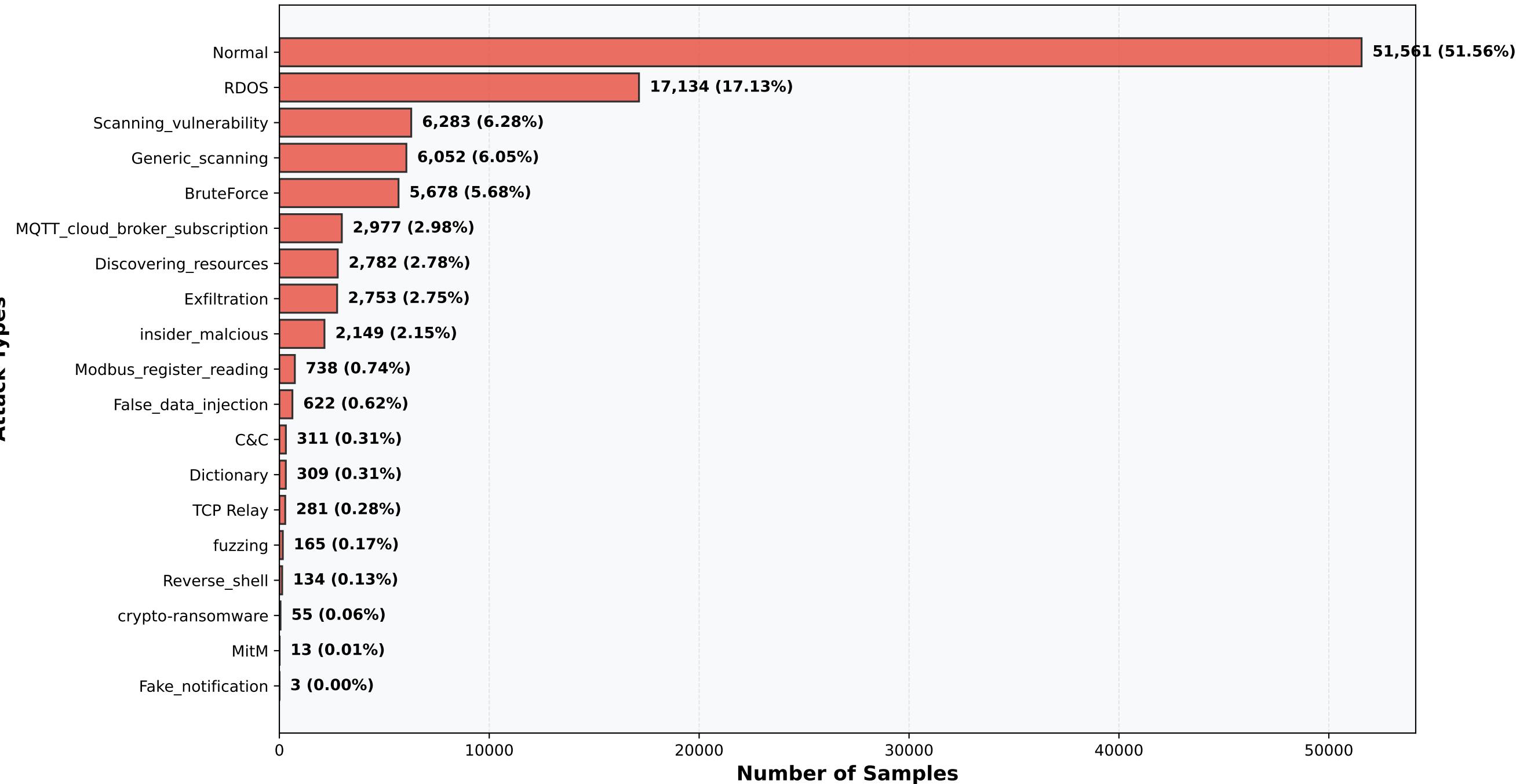
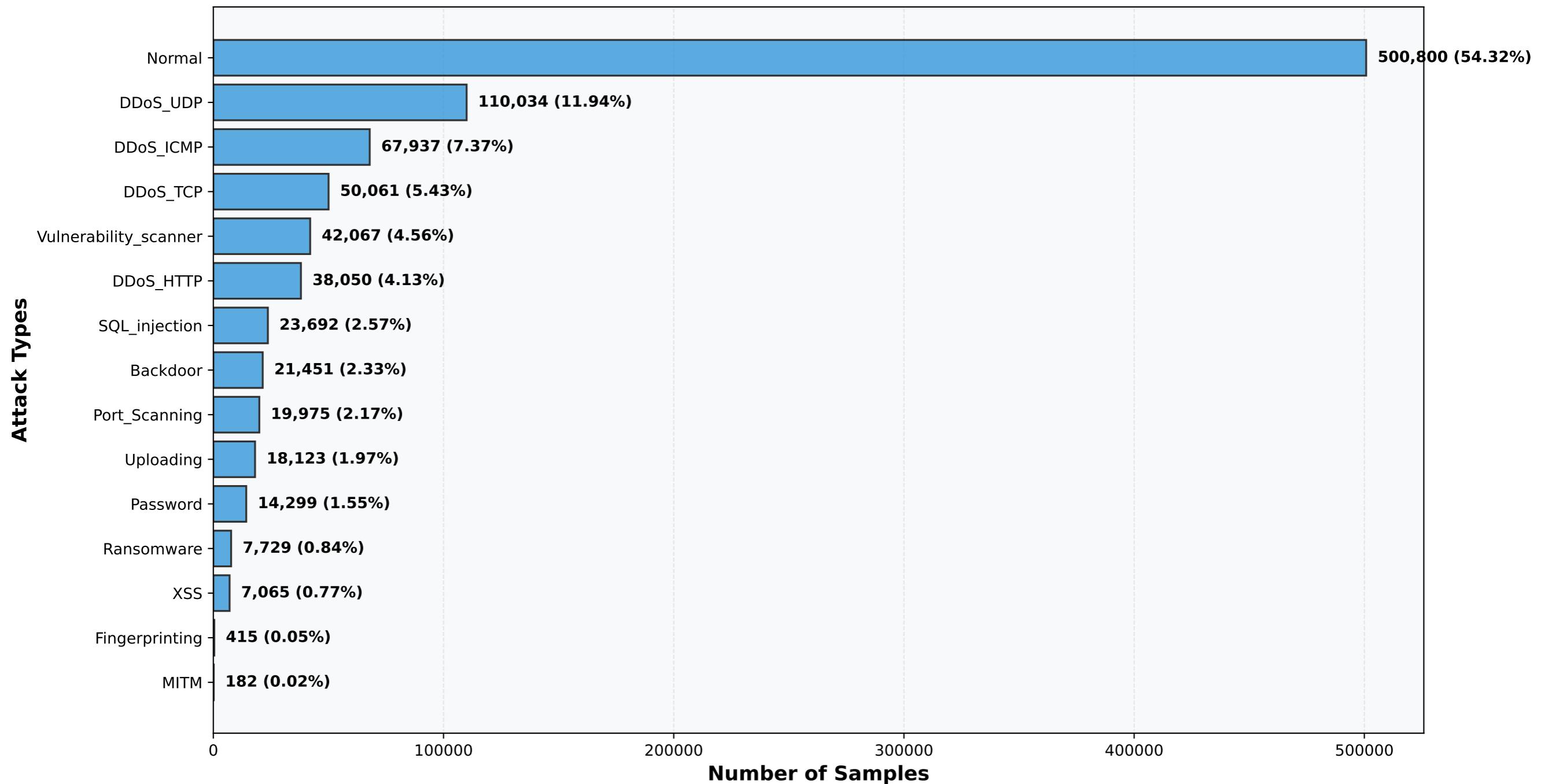


Dataset 1 (X-IIoTID) - Attack Distribution
Total Samples: 100,000

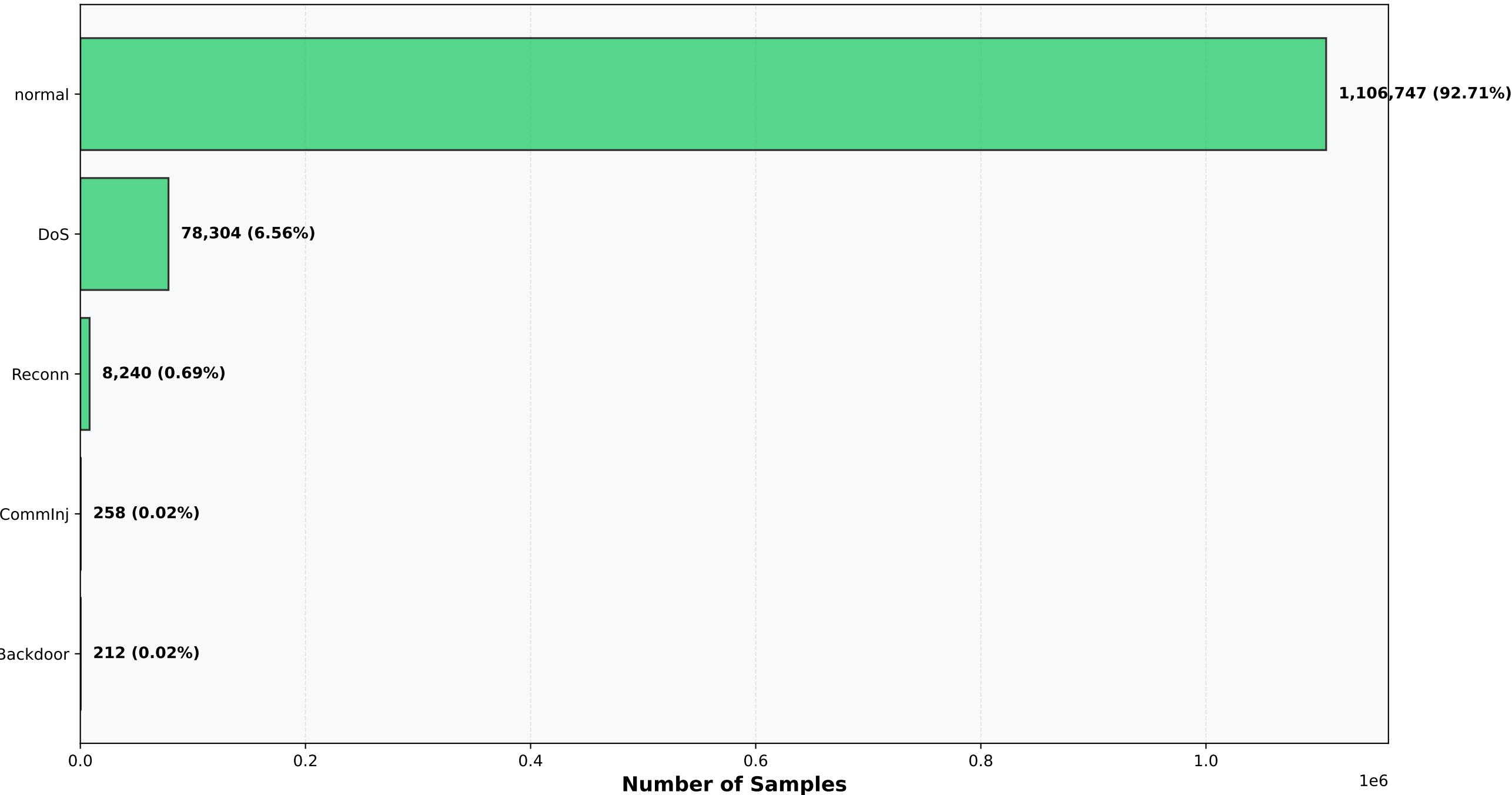


Dataset 2 (Edge-IoTset) - Attack Distribution

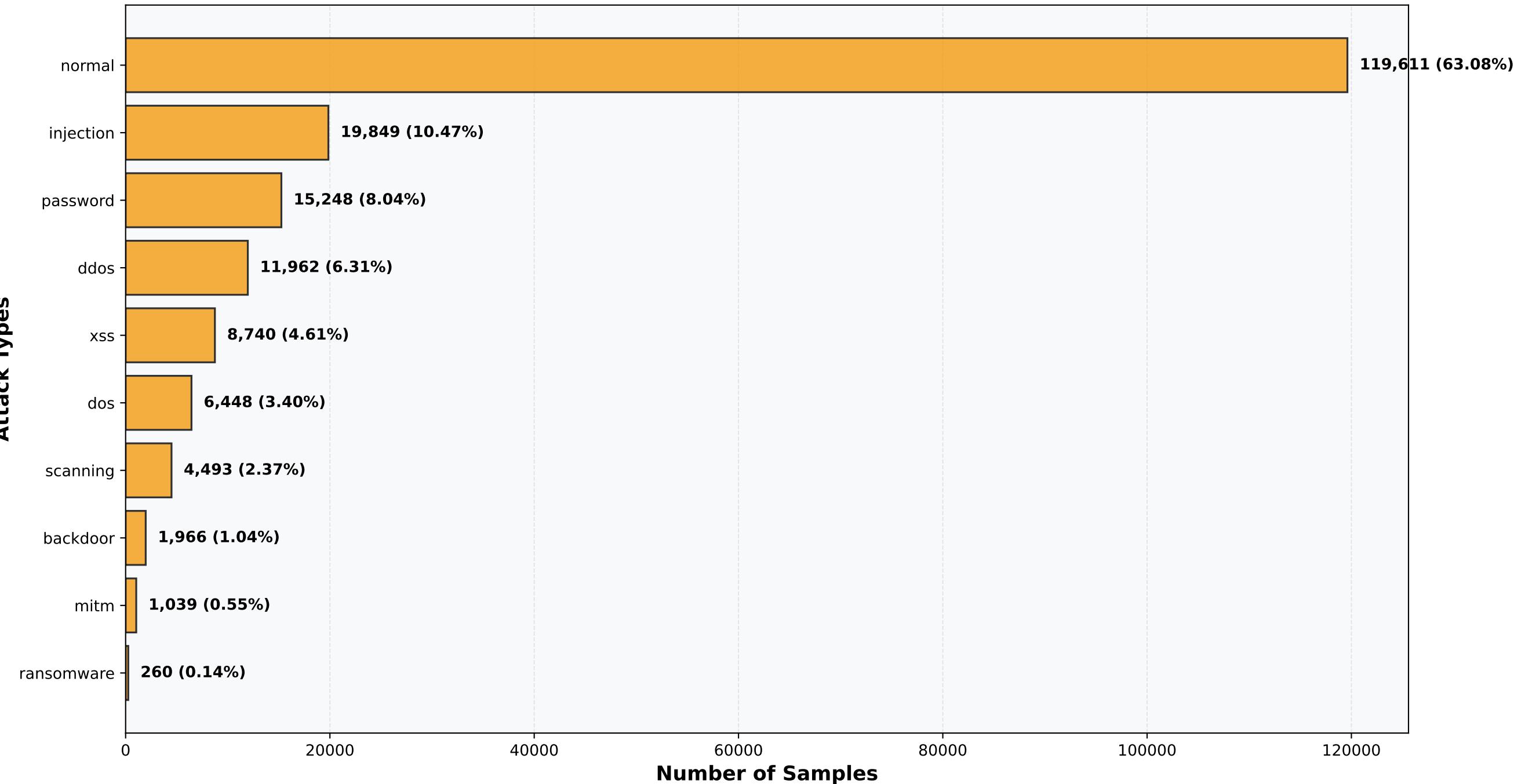
Total Samples: 921,880



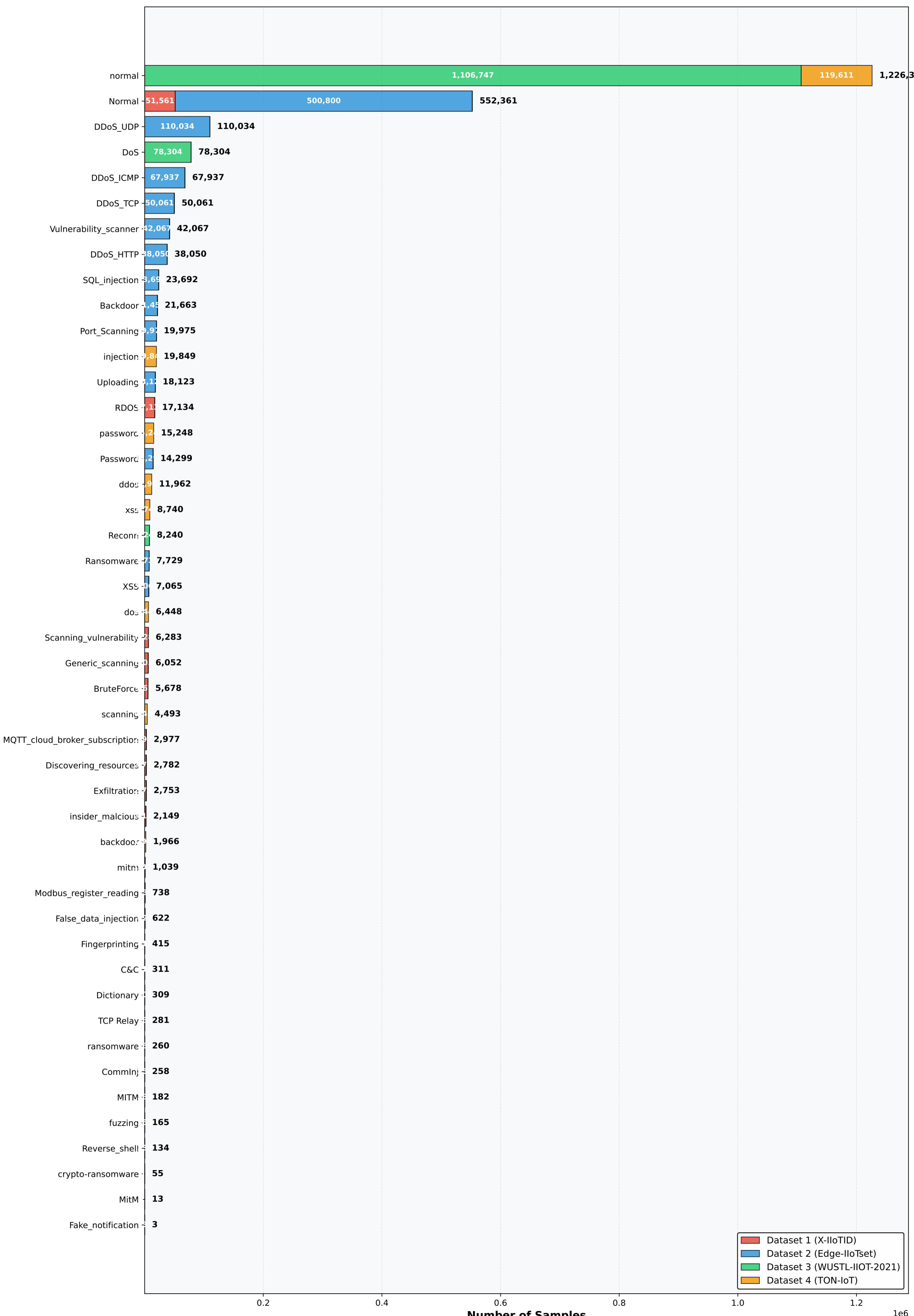
Dataset 3 (WUSTL-IIOT-2021) - Attack Distribution
Total Samples: 1,193,761



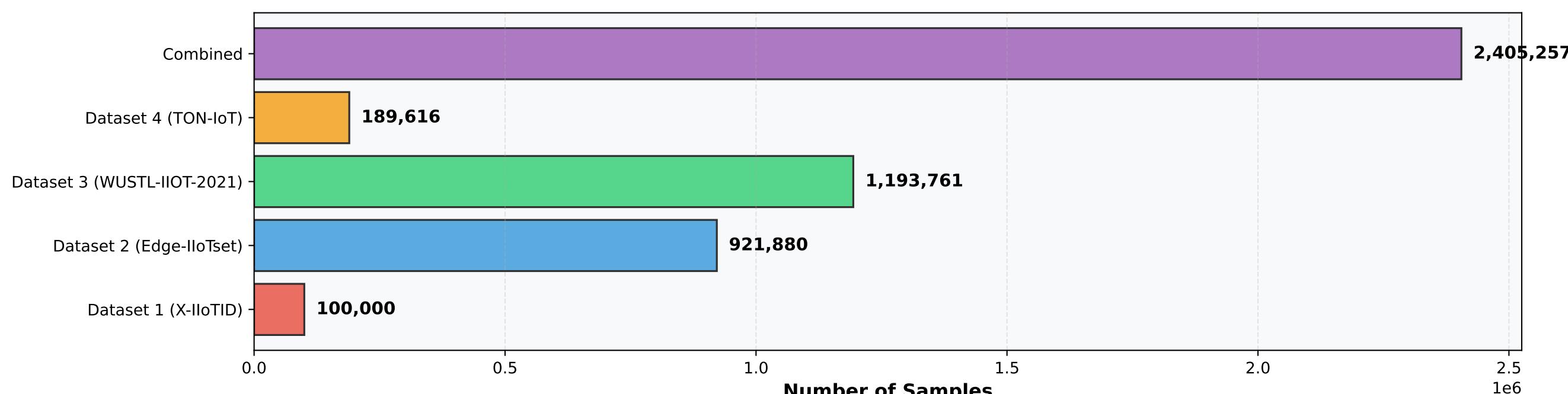
Dataset 4 (TON-IoT) - Attack Distribution
Total Samples: 189,616



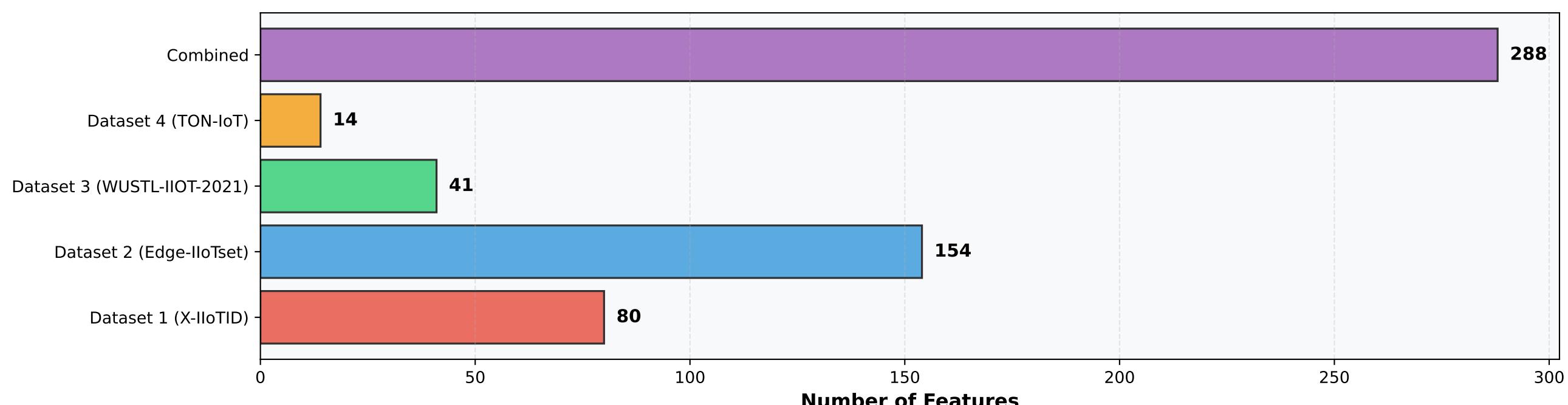
Combined Dataset - Attack Distribution by Source
Total Samples: 2,405,257



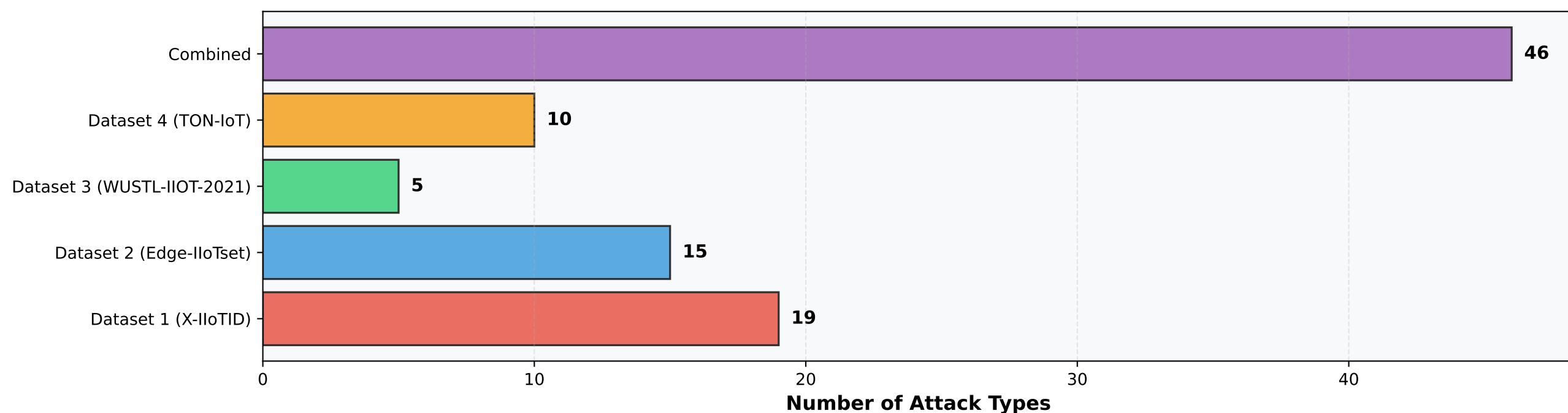
Dataset Comparison - Sample Counts

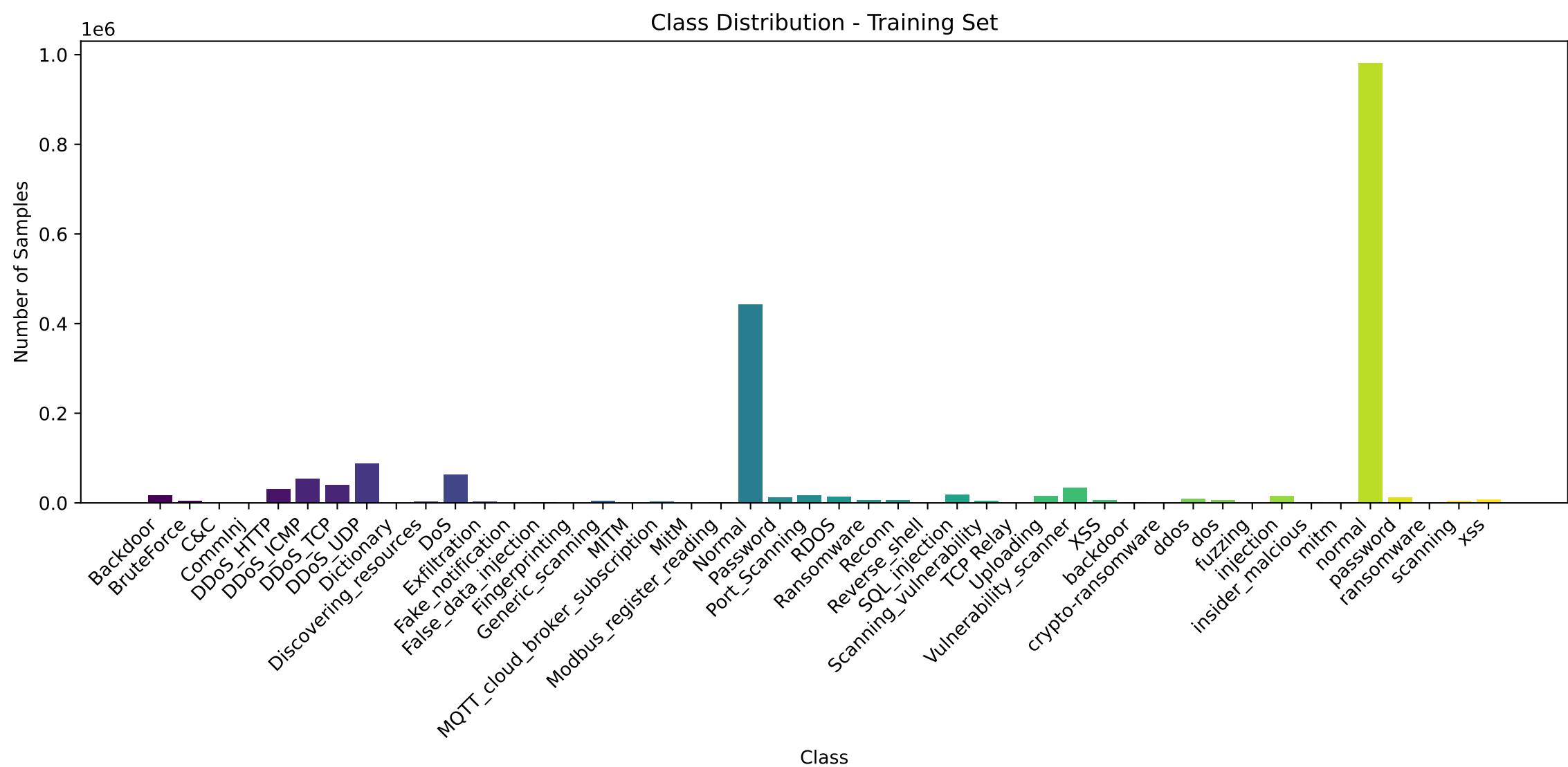


Dataset Comparison - Feature Counts

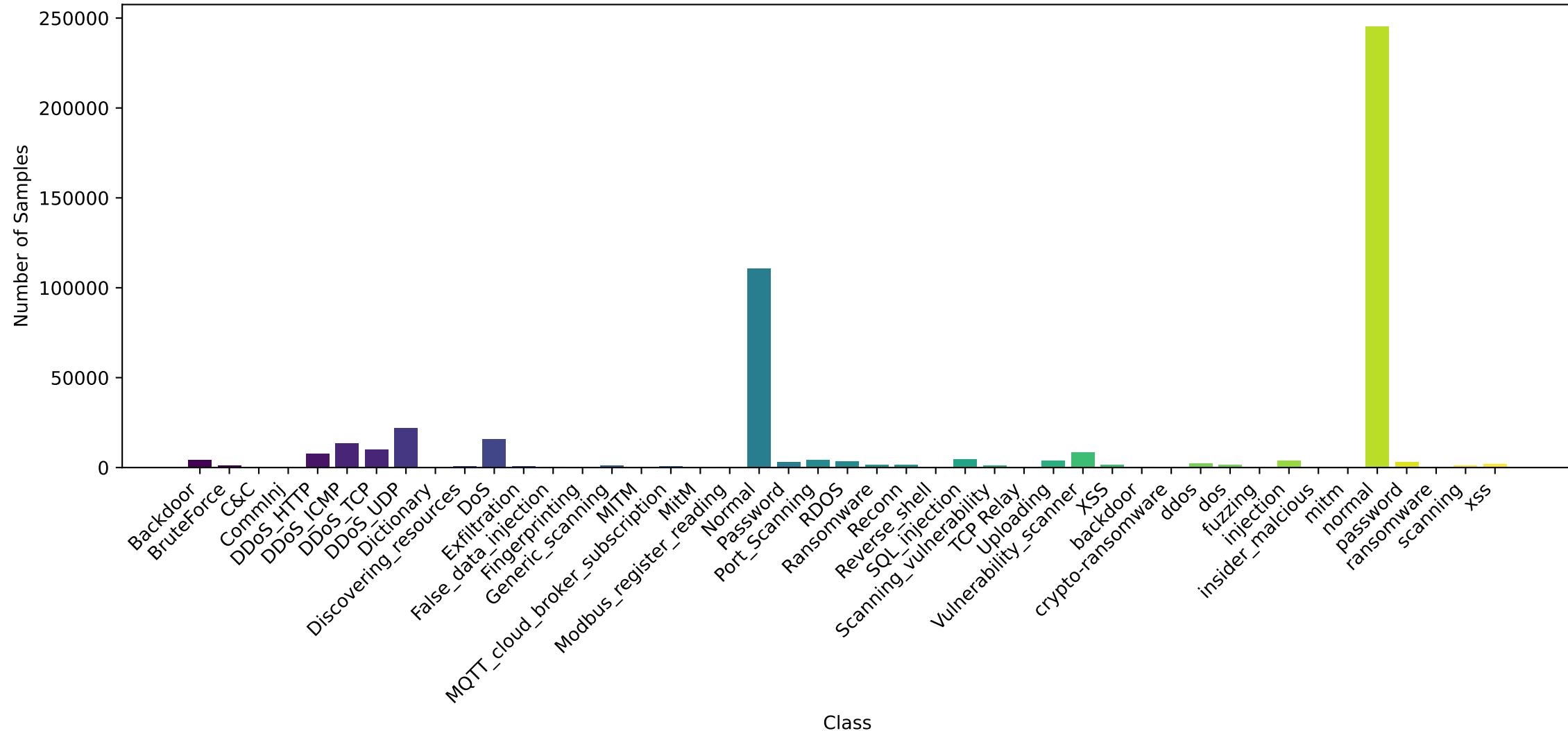


Dataset Comparison - Attack Type Diversity





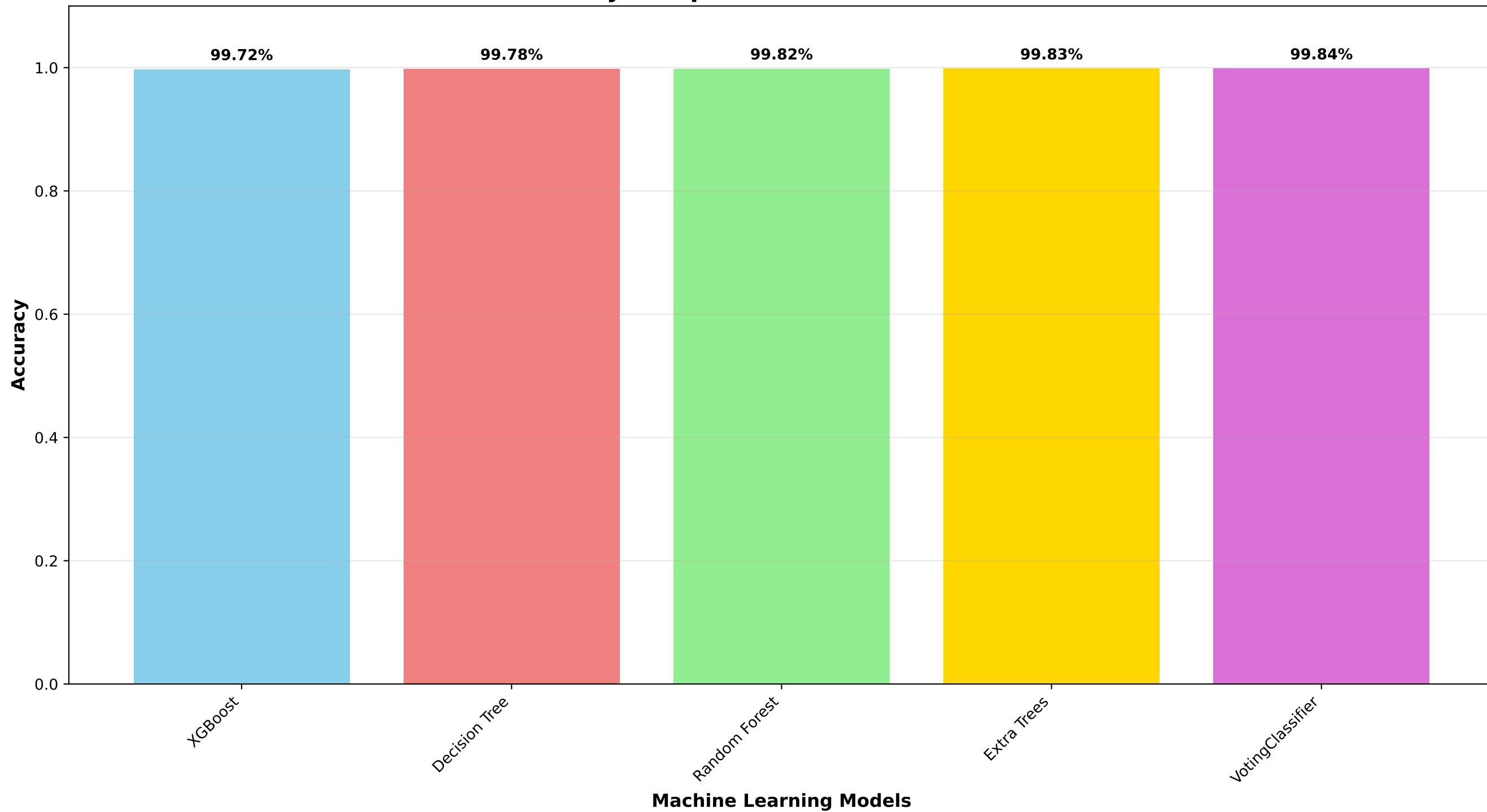
Class Distribution - Test Set



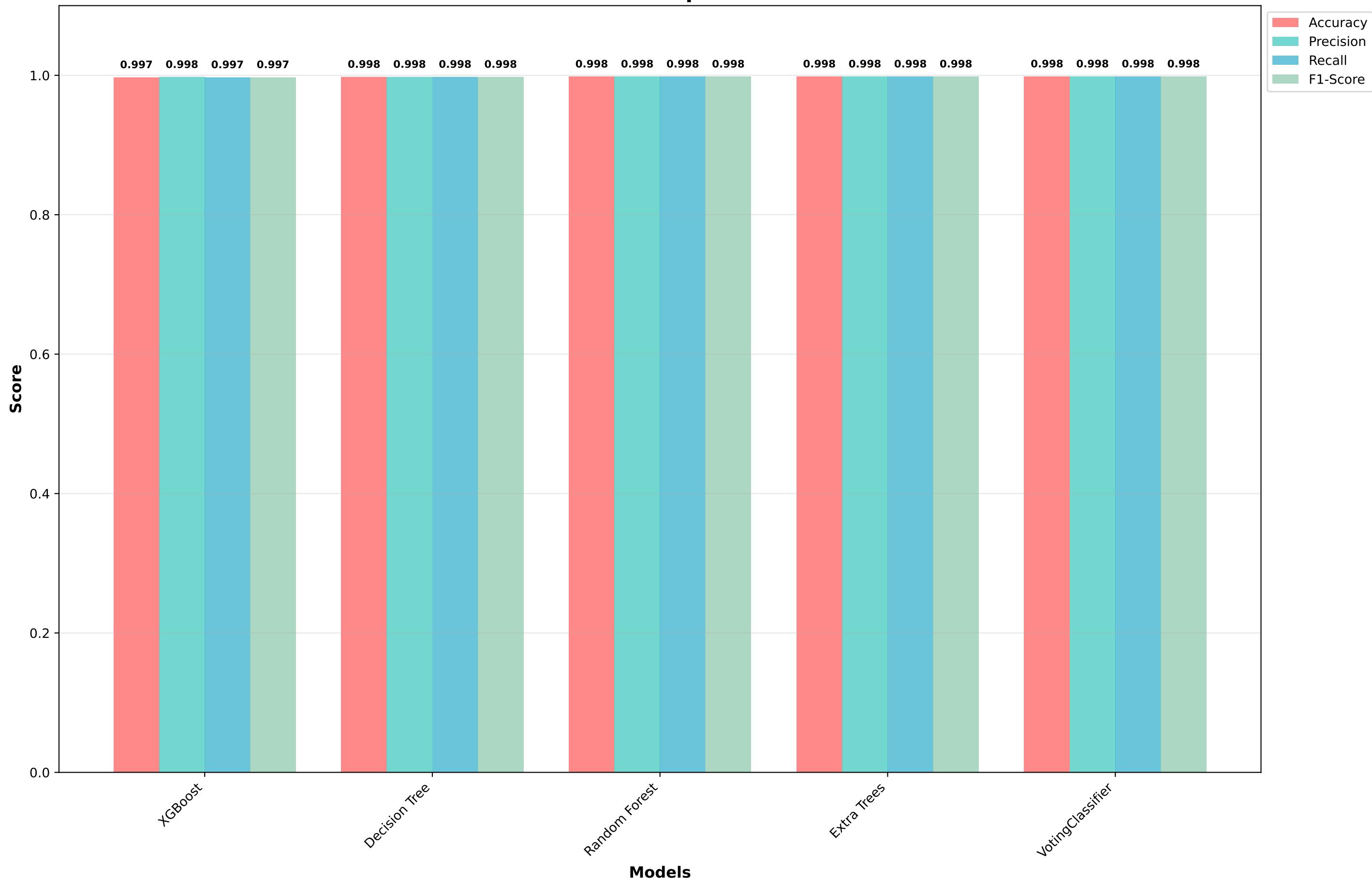
Model Performance Summary

Model	Accuracy	Precision	Recall	F1-Score
XGBoost	0.9972	0.9975	0.9972	0.9973
Decision Tree	0.9978	0.9978	0.9978	0.9978
Random Forest	0.9982	0.9982	0.9982	0.9981
Extra Trees	0.9983	0.9982	0.9983	0.9982
VotingClassifier	0.9984	0.9984	0.9984	0.9984

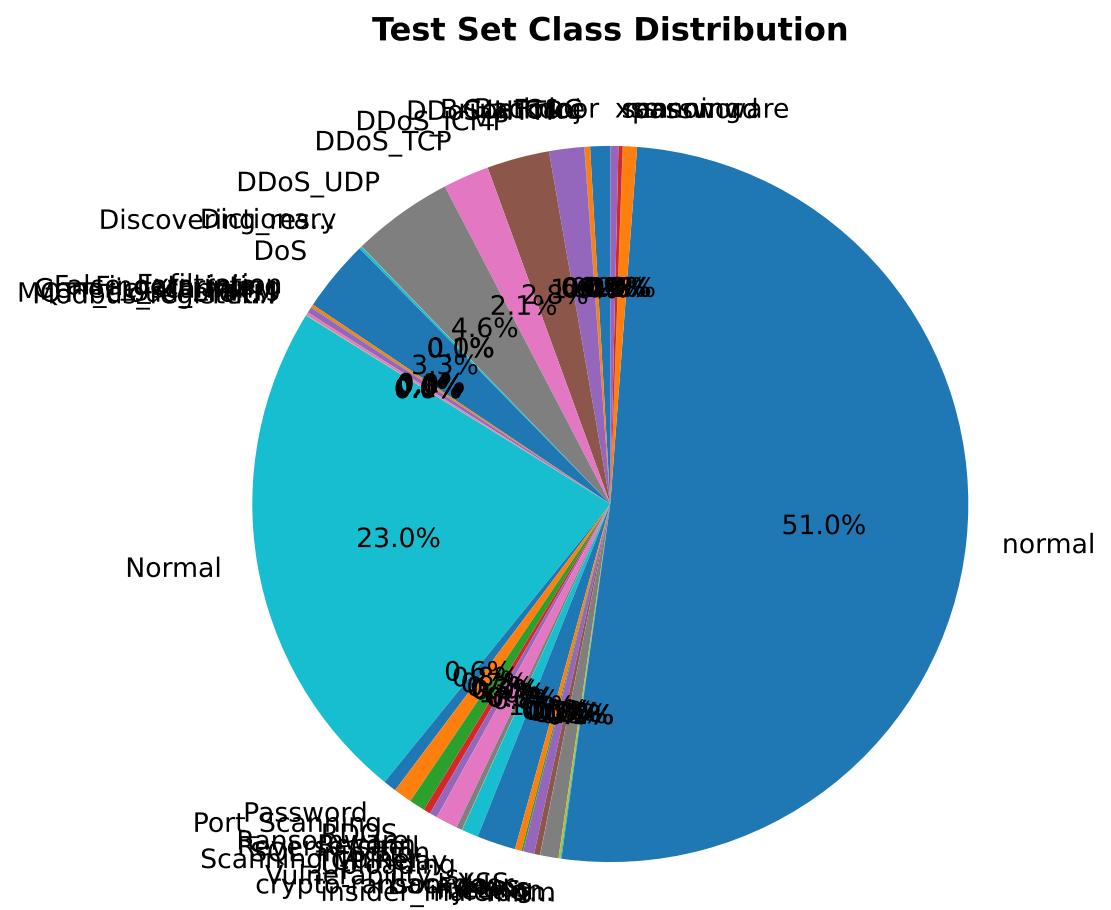
Accuracy Comparison of Different Models



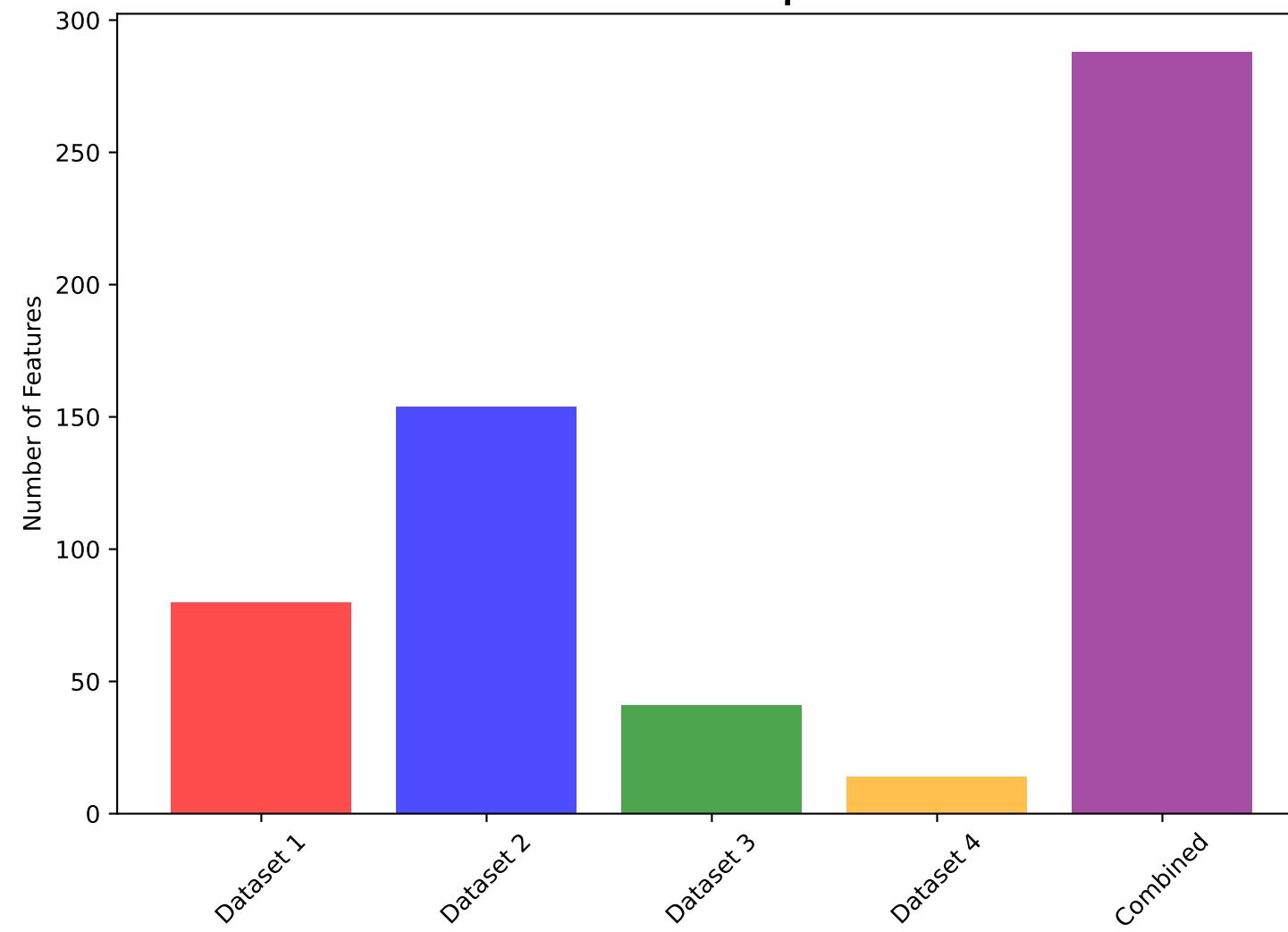
Model Performance Comparison - All Metrics



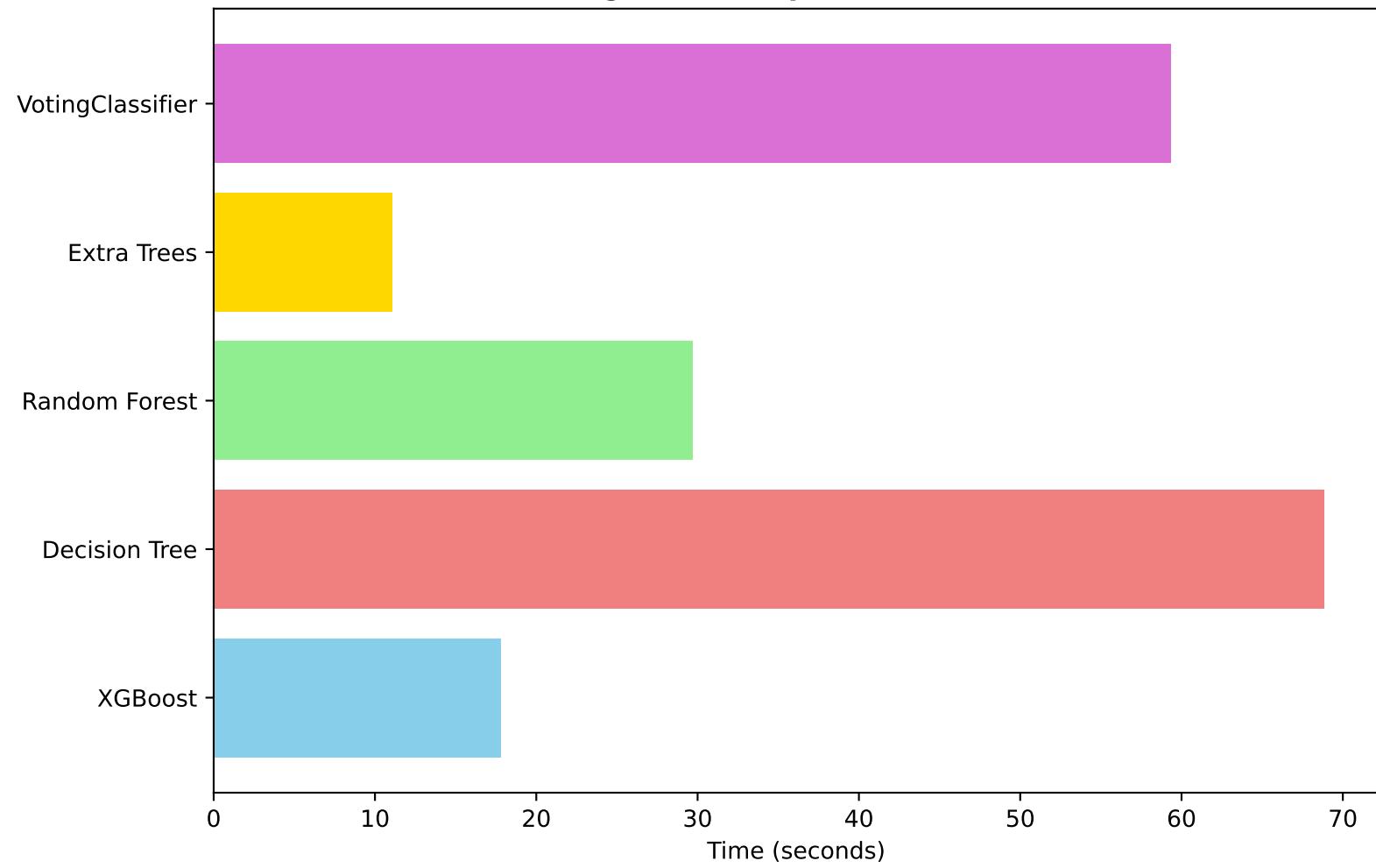
Detailed Analysis Statistics



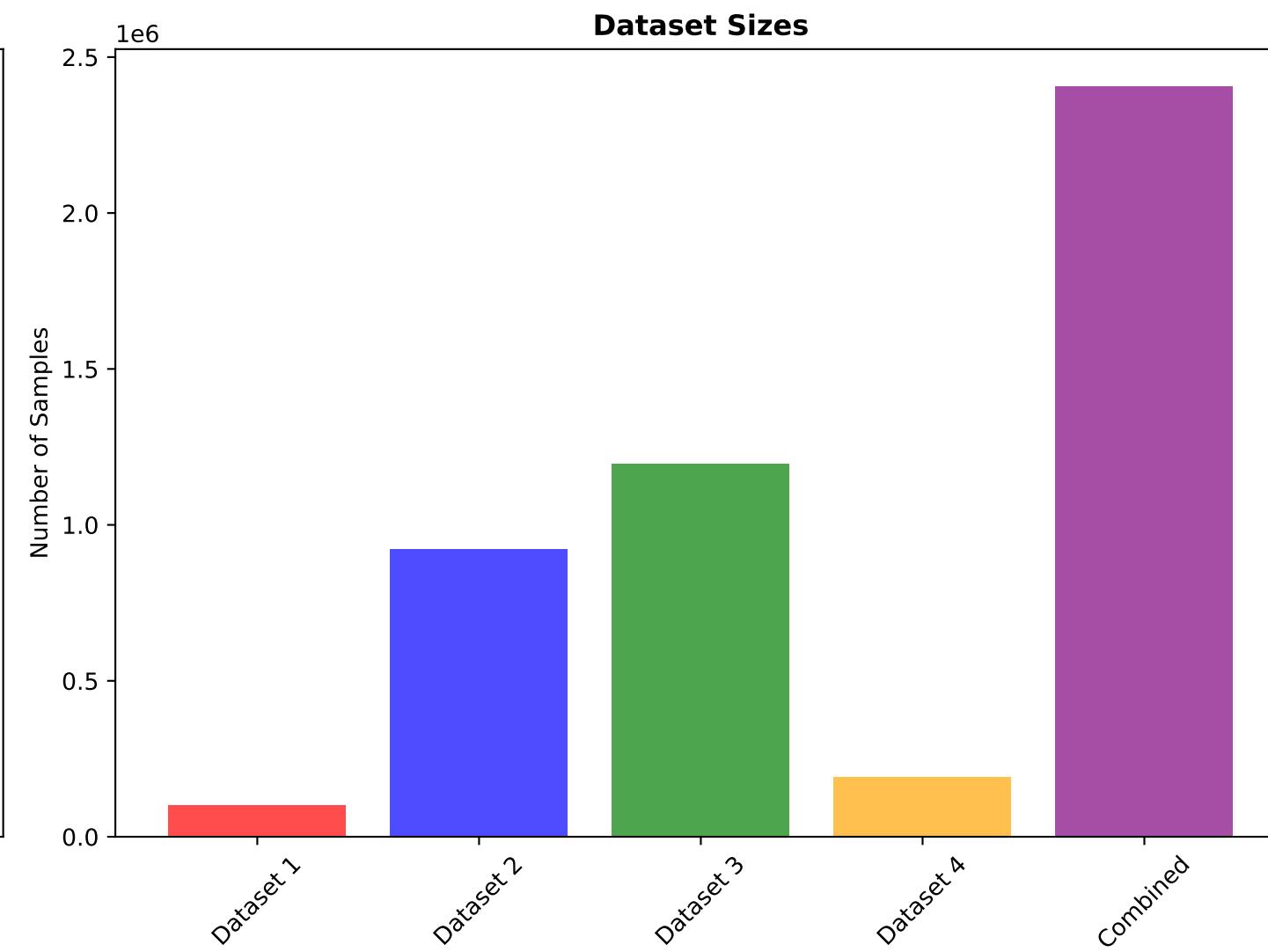
Number of Features per Dataset



Training Time Comparison (simulated)



Dataset Sizes



Analysis Metadata and Summary

MACHINE LEARNING ANALYSIS REPORT

Analysis Date: 2025-10-12 20:02:52

DATASETS USED:

- Dataset 1 (X-IIoTID): 100,000 samples, 80 features
- Dataset 2 (Edge-IIoTset): 921,880 samples, 154 features
- Dataset 3 (WUSTL-IIOT-2021): 1,193,761 samples, 41 features
- Dataset 4 (TON-IoT): 189,616 samples, 14 features

COMBINED DATASET:

- Total Samples: 2,405,257
- Total Features: 288
- Training Samples: 1,924,205
- Test Samples: 481,052
- Number of Classes: 45

MODELS EVALUATED:

- XGBoost Classifier
- Decision Tree Classifier
- Random Forest Classifier
- Extra Trees Classifier
- Voting Classifier (Ensemble)

BEST PERFORMING MODEL:

VotingClassifier
(Accuracy: 0.9984)

PREPROCESSING STEPS:

- Feature harmonization using UNION strategy
- Missing value imputation with median strategy
- Label encoding and standardization
- Outlier removal and feature engineering
- Train/test split with stratification